

**Notice of References Cited**

Application/Control No.

10/578,780

Applicant(s)/Patent Under  
Reexamination  
TANOUE ET AL.

Examiner

Tan V. Mai

Art Unit

2193

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,844,828	12-1998	Fujimura et al.	708/209
*	B	US-5,822,231	10-1998	Wong et al.	708/209
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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